

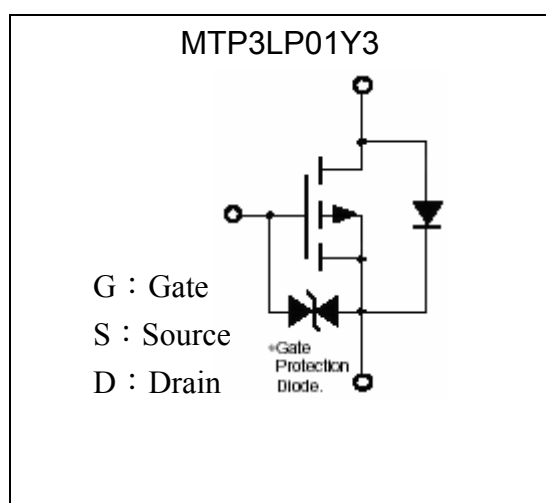
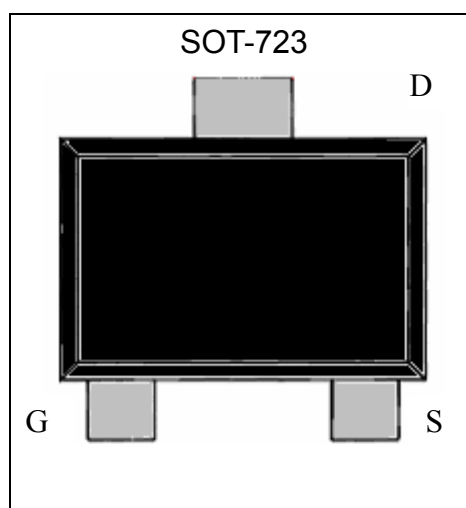
**30V P-CHANNEL Enhancement Mode MOSFET**

# MTP3LP01Y3

$BV_{DSS}$	-30V
$I_D$	-230mA
$R_{DS(on)(typ)}$	$3\Omega @ -4V$
	$4.6\Omega @ -2.5V$
	$10.9\Omega @ -1.5V$

**Features**

- Ultra high speed switching.
- Low gate charge.
- 2.5V drive.
- Pb-free package lead plating and halogen-free package.

**Equivalent Circuit**

**Outline**

**Absolute Maximum Ratings** (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	±10	V
Continuous Drain Current	$I_D$	-230	mA
Pulsed Drain Current (Note 1)	$I_{DM}$	-920	mA
Maximum Power Dissipation (Note 2)	$P_D$	150	mW
Thermal Resistance, Junction-to-Ambient	$R_{th,ja}$	833	°C/W
Operating Junction and Storage Temperature	$T_j, T_{stg}$	-55~+150	°C

Note : 1. Pulse width ≤ 10μs, duty cycle ≤ 1%.  
 2. When mounted on a glass epoxy with a dimension of 100mm<sup>2</sup> × 1mm.



**Electrical Characteristics** (Ta=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	-30	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA
V <sub>GS(th)</sub>	-0.6	0.9	-1.1	V	V <sub>DS</sub> =-10V, I <sub>D</sub> =-100μA
G <sub>FS</sub>	100	210	-	mS	V <sub>DS</sub> =-10V, I <sub>D</sub> =-100mA
I <sub>GSS</sub>	-	-	±1	μA	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	-1	μA	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0
	-	-	-10		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0; T <sub>j</sub> =125°C
*R <sub>DS(ON)</sub>	-	3	5	Ω	V <sub>GS</sub> =-4V, I <sub>D</sub> =-100mA
	-	4.6	8		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-30mA
	-	10.9	18		V <sub>GS</sub> =-1.5V, I <sub>D</sub> =-1mA
<b>Dynamic</b>					
C <sub>iss</sub>	-	35.7	-	pF	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0, f=1MHz
C <sub>oss</sub>	-	11.9	-		
C <sub>rss</sub>	-	3.7	-		
*t <sub>d(ON)</sub>	-	26.4	-	ns	V <sub>DS</sub> =-15V, I <sub>D</sub> =-100mA, V <sub>GS</sub> =-4V, R <sub>L</sub> =150Ω, R <sub>G</sub> =50Ω
*t <sub>r</sub>	-	12.8	-		
*t <sub>d(OFF)</sub>	-	31.5	-		
*t <sub>f</sub>	-	46.4	-		
*Q <sub>g</sub>	-	0.78	-	nC	V <sub>DS</sub> =-10V, I <sub>D</sub> =-100mA, V <sub>GS</sub> =-10V
*Q <sub>gs</sub>	-	0.1	-		
*Q <sub>gd</sub>	-	0.1	-		
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	-230	mA	
*I <sub>SM</sub>	-	-	-920		
*V <sub>SD</sub>	-	0.83	-1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-100mA

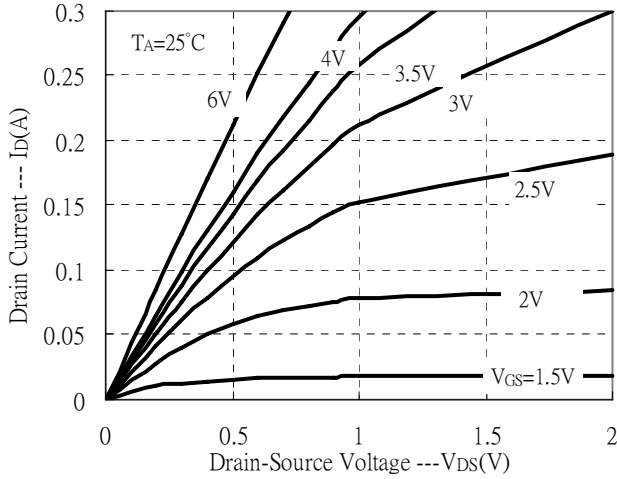
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

**Ordering Information**

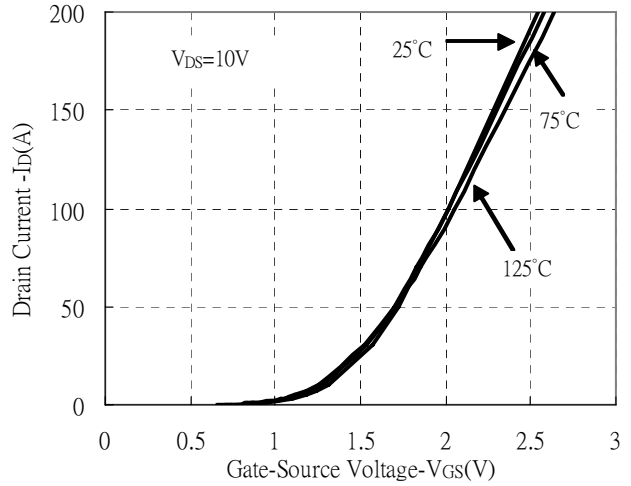
Device	Package	Shipping	Marking
MTP3LP01Y3	SOT-723 (Pb-free lead plating and halogen-free package)	8000 pcs / Tape & Reel	AB

**Typical Characteristics**(The minus sign in voltage and current is omitted)

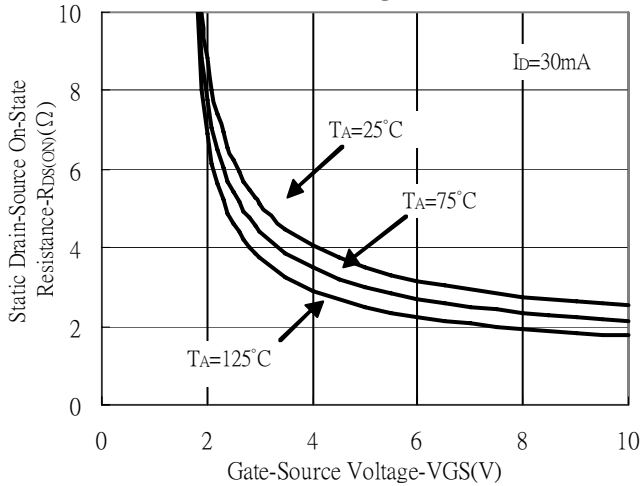
Typical Output Characteristics



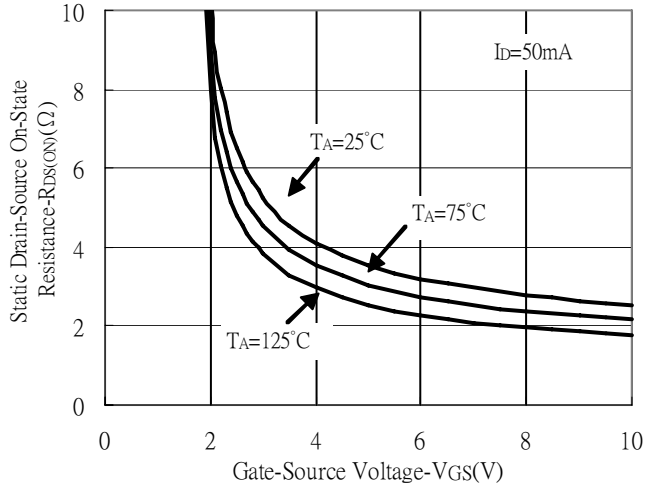
Typical Transfer Characteristics



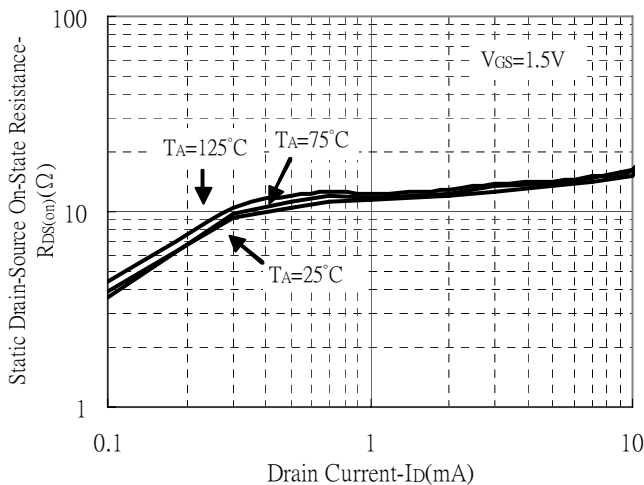
Static Drain-Source On-State Resistance vs Gate-Source Voltage



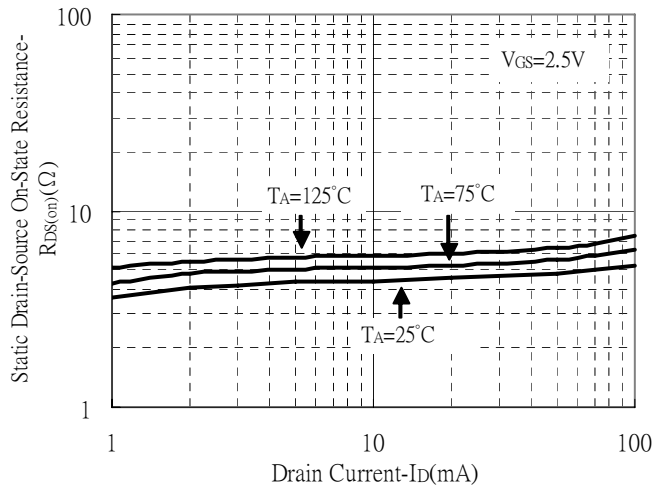
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Static Drain-Source On-State resistance vs Drain Current

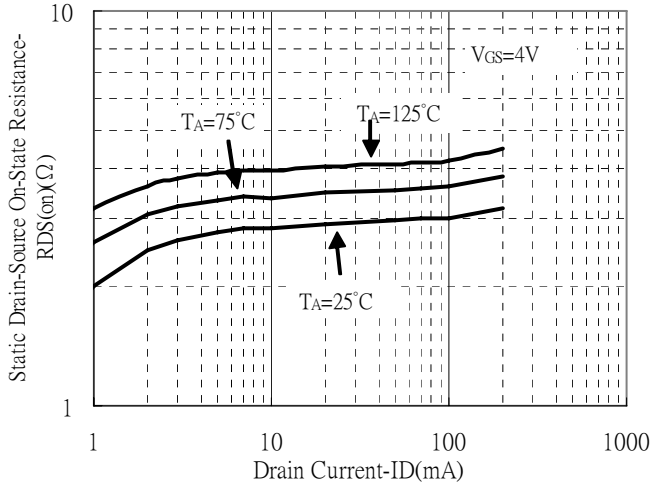


Static Drain-Source On-State resistance vs Drain Current

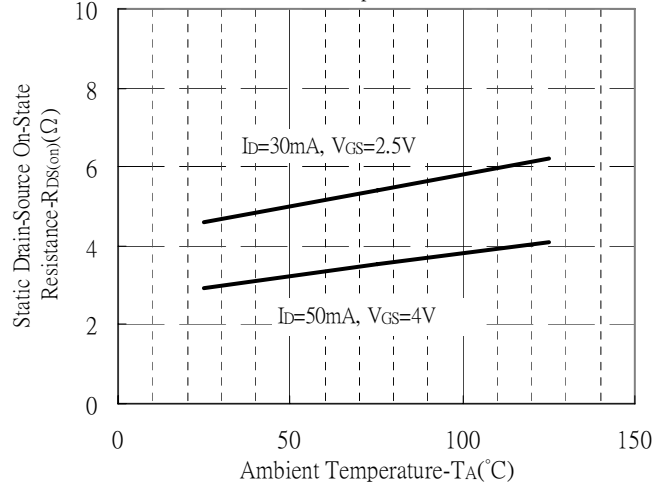


**Typical Characteristics(Cont.)**

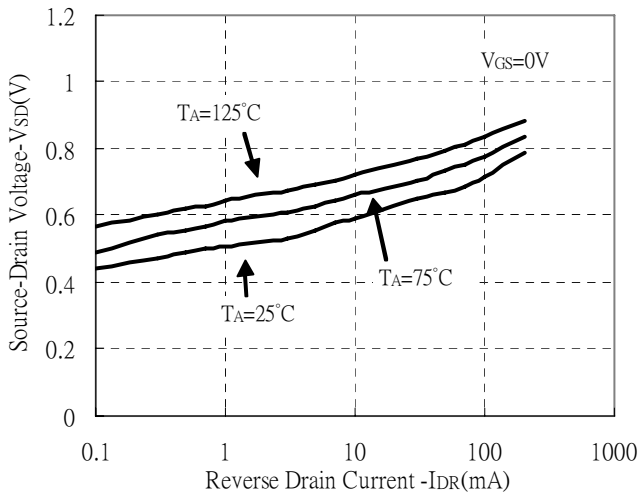
Static Drain-Source On-State resistance vs Drain Current



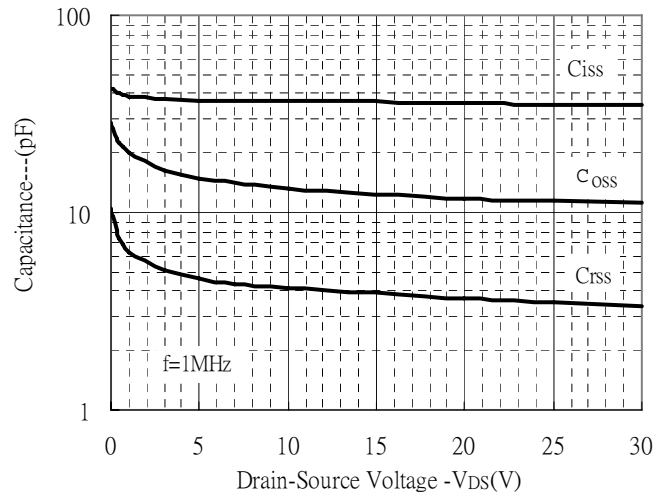
Static Drain-Source On-State resistance vs Ambient Temperature



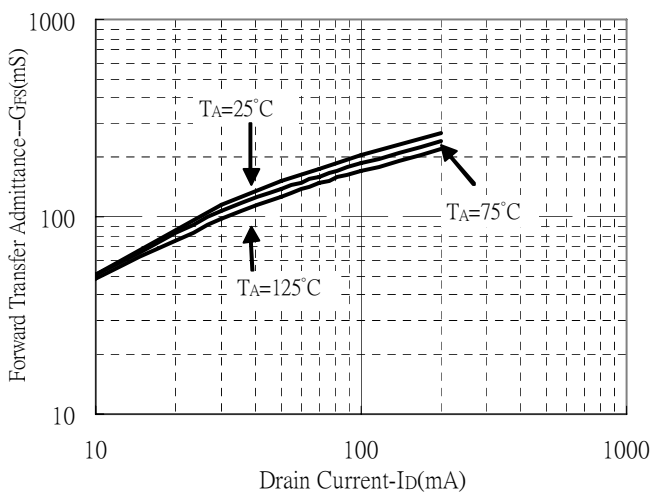
Reverse Drain Current vs Source-Drain Voltage



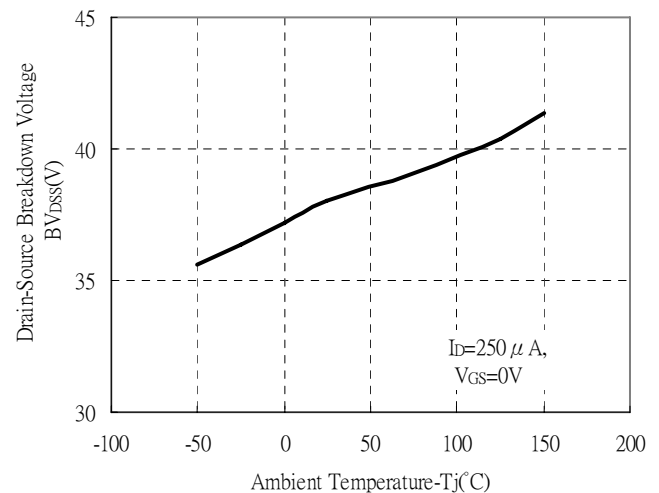
Capacitance vs Drain-to-Source Voltage



Forward Transfer Admittance vs Drain Current

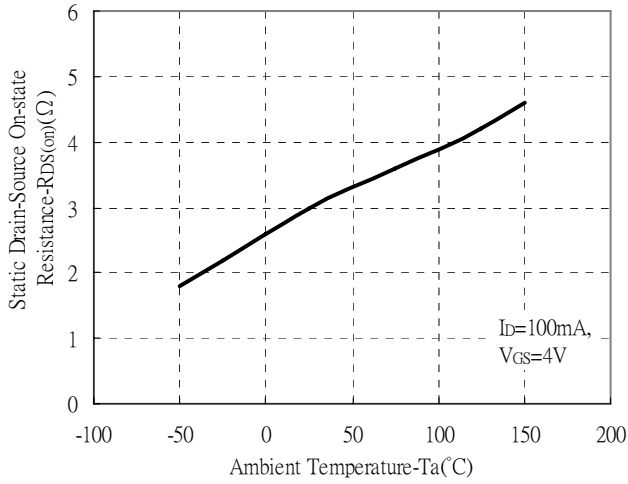


Brekdown Voltage vs Ambient Temperature

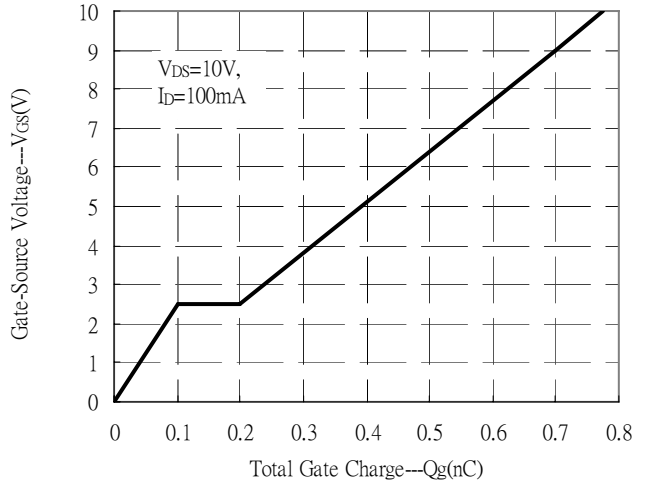


**Typical Characteristics(Cont.)**

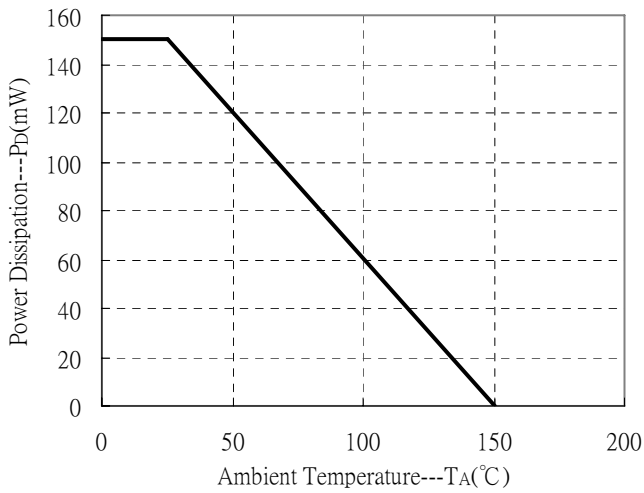
Static Drain-Source On-resistance vs Ambient Temperature



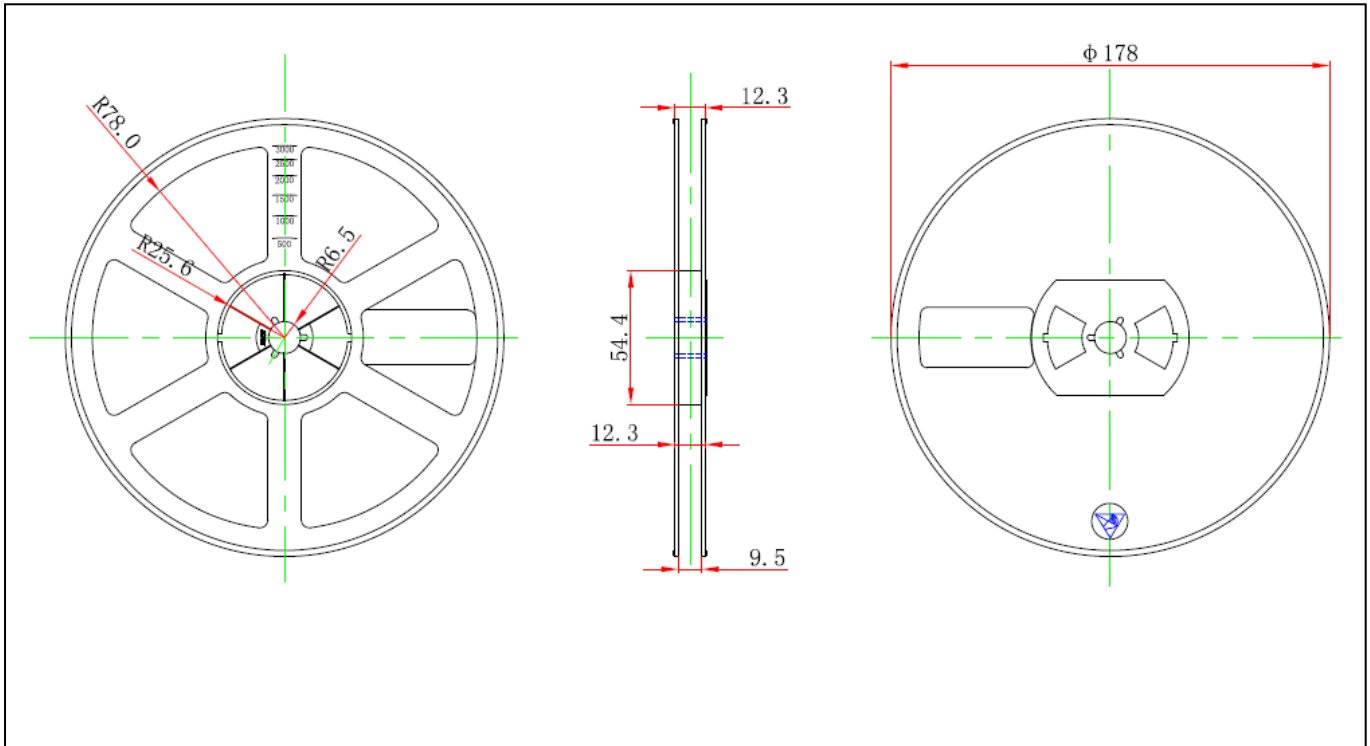
Gate Charge Characteristics



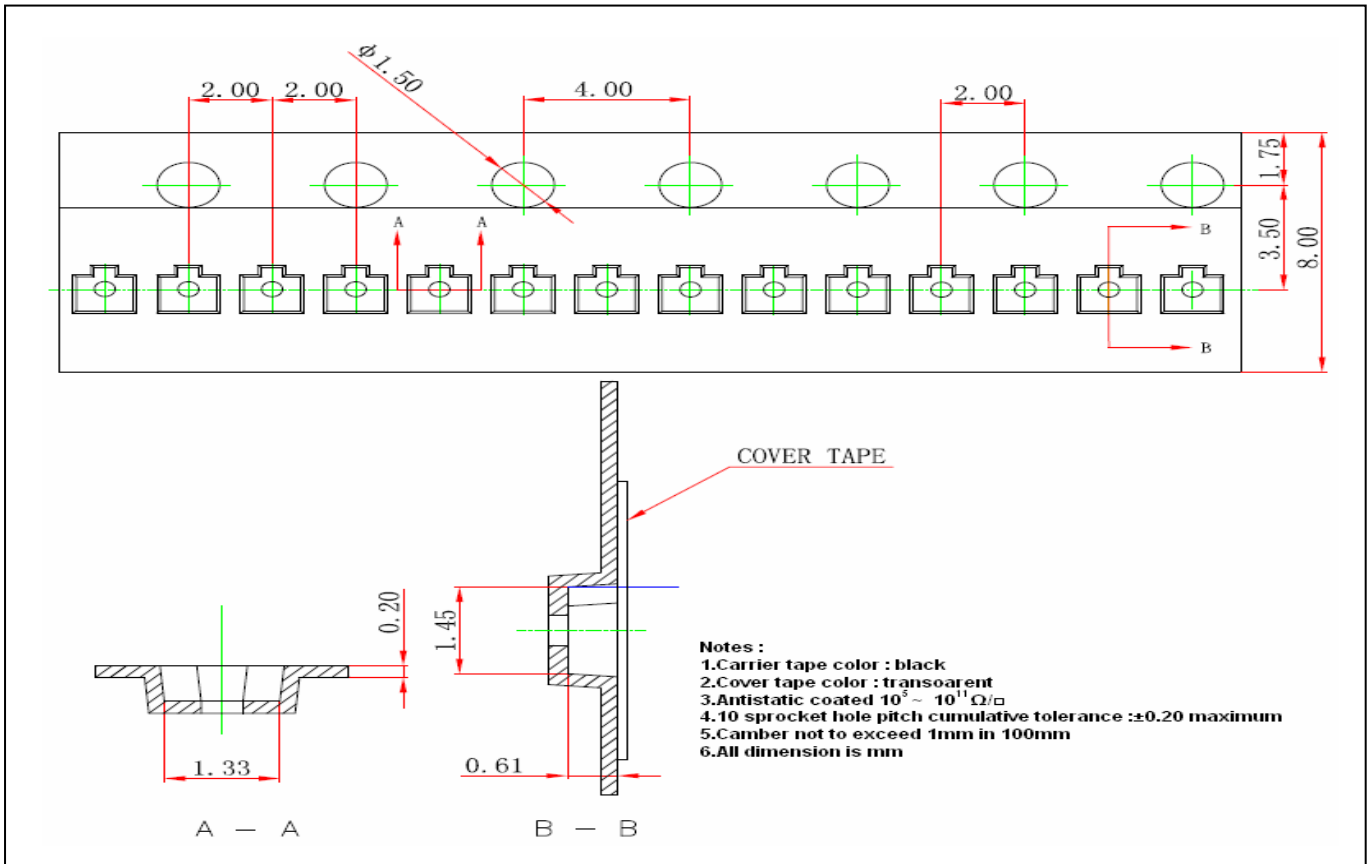
Power Derating Curve



**Reel Dimension**



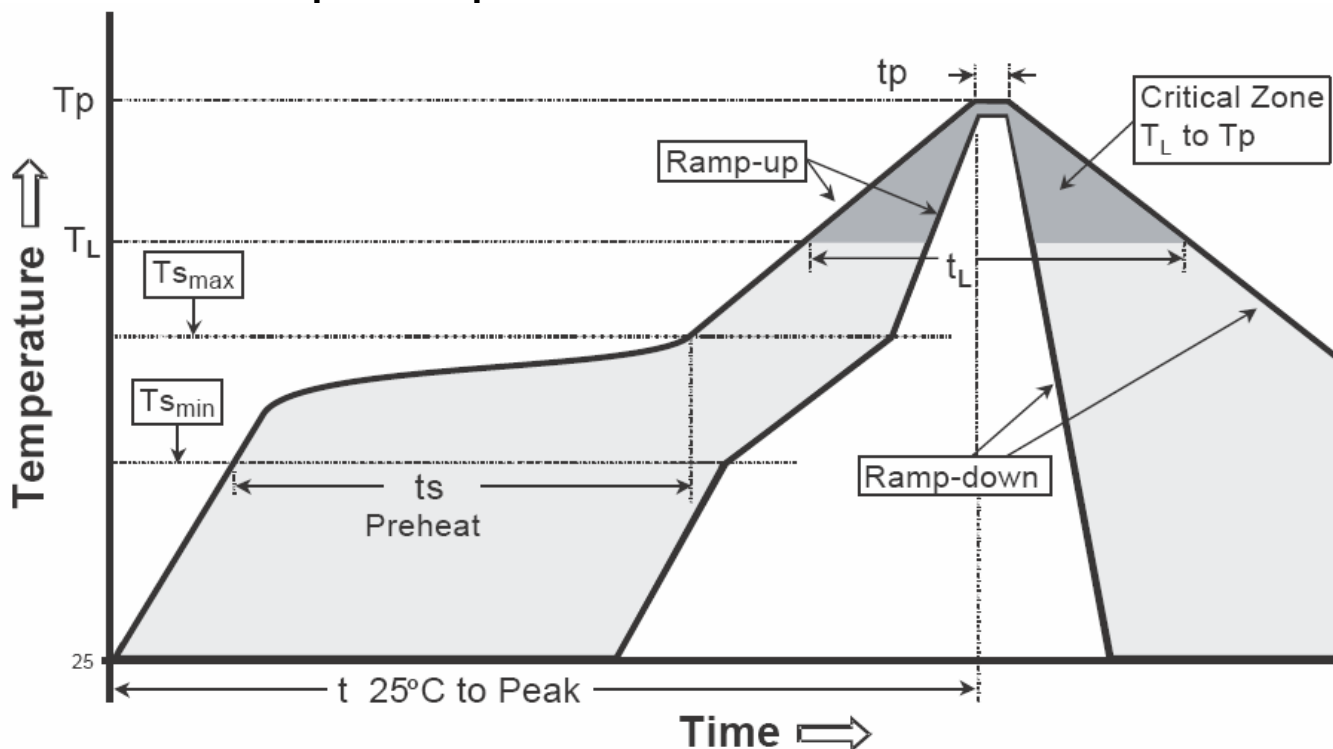
**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

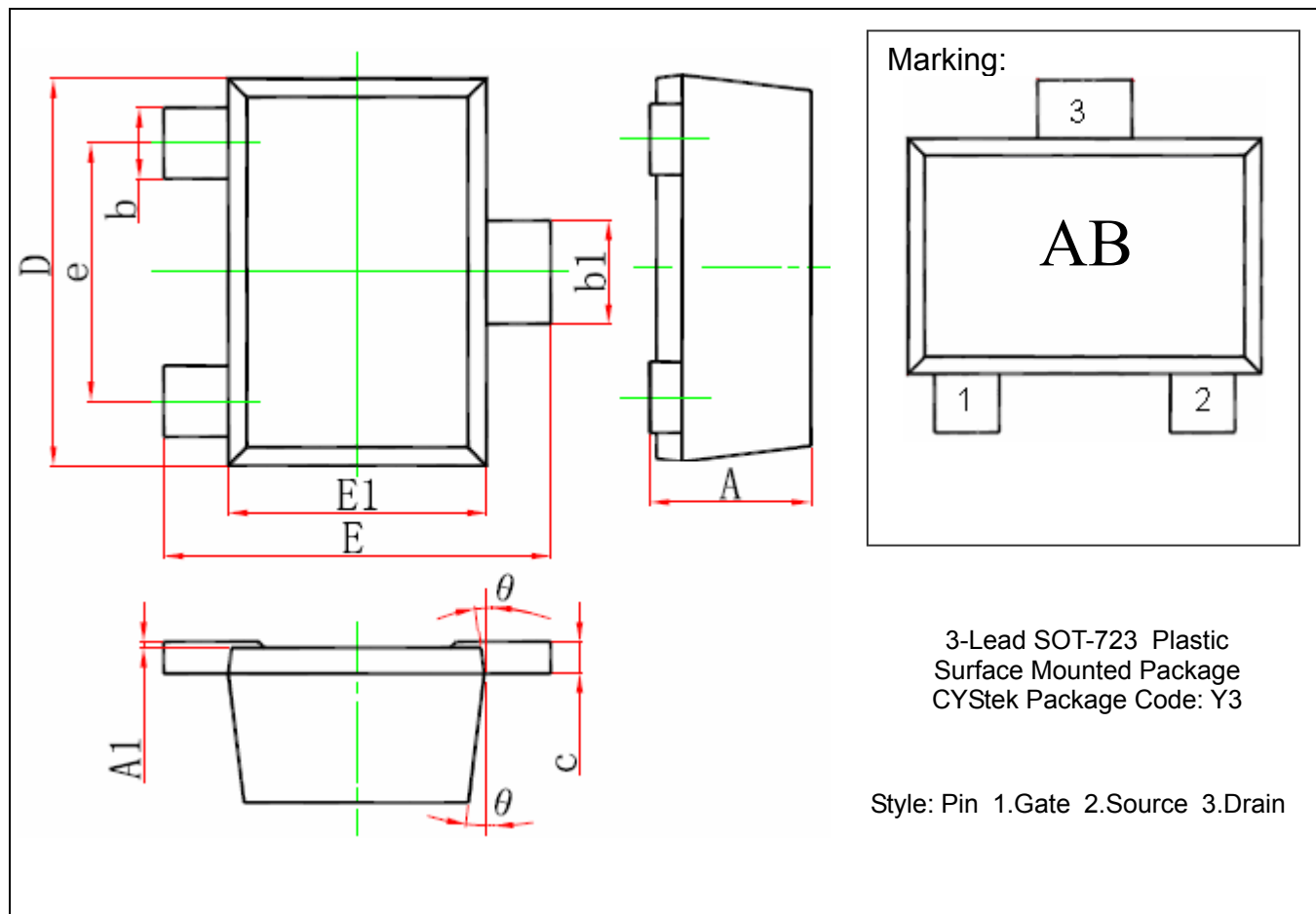
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**SOT-723 Dimension**



\*Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.000	0.500	0.000	0.020	D	1.150	1.250	0.045	0.049
A1	0.000	0.050	0.000	0.002	E	1.150	1.250	0.045	0.049
b	0.170	0.270	0.007	0.011	E1	0.750	0.850	0.030	0.033
b1	0.270	0.370	0.011	0.015	e	0.800*		0.031*	
c	0.000	0.150	0.000	0.006	$\theta$	7° REF		7° REF	

**Notes:** 1.Controlling dimension: millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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